

## High Power Density Silicon Carbide Power Electronic Converters

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## Overview

- **Broader Impact of SiC-based Power Converter**
- **Development of 10-kVA SiC Inverter**
  - **APEI's Goals**
  - **SiC Power Devices Selection and Characterization**
  - **Testing of 10-kVA All SiC Inverter Prototype**
- **Summary**

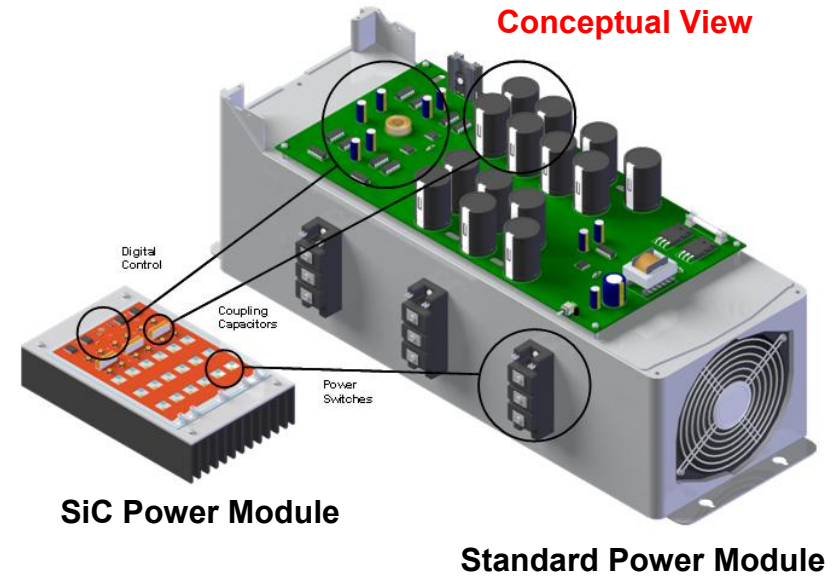
## Advantages of Silicon Carbide (SiC)

### Theoretical Electrical Advantages

- Very high voltage blocking
- Very low switching losses (up to 1/10<sup>th</sup> of Silicon)
- Low on-resistance
- Up to 10s of GHz switching range

### Theoretical Thermal Advantages

- SiC device theoretical limit exceeds 600 °C  
**Very high power densities can be achieved with these junction temperatures**
- SiC has a very high thermal conductivity—excellent for power devices and thermal transfer, increases power density
- **Disadvantage:** No device packaging technology exists to take full advantage of thermal capabilities  
**Requires packaging advances in die attach, interconnects, and reliability**



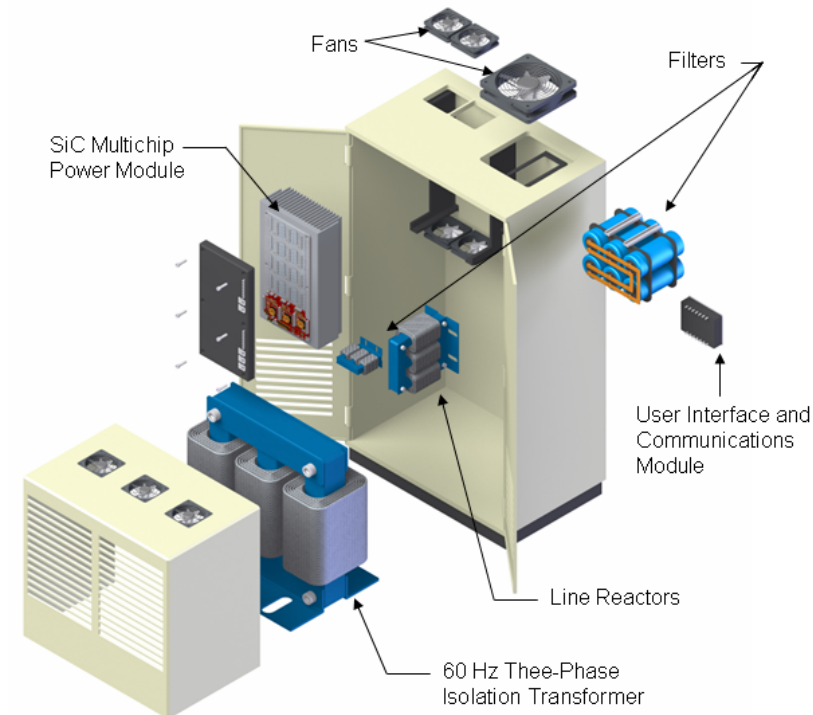


## DOE ESS Phase II SBIR (FY06)

- Phase II started on August 2006
- Goals of Phase II:
  1. Develop a higher power SiC-based fully-functional multi-purpose inverter
  2. Improved efficiency (>96%)
  3. Large weight and volume reduction
  4. Similar functionality

- Ratings of Phase II Prototype

- Power: 10 kVA
- VDC from 350V to 700 V
- Efficiency > 96%
- Ambient Temperature > 75 °C
- Weight << 100 lbs
- Volume << 2.5 cubic foot
- Other Important parameters:
  - Maximum AC current ~ 31 Arms
  - AC output current THD < 5 %
  - Maximum DC current ~32 A



## SiC Devices Presently “Available”

### SiC Diodes

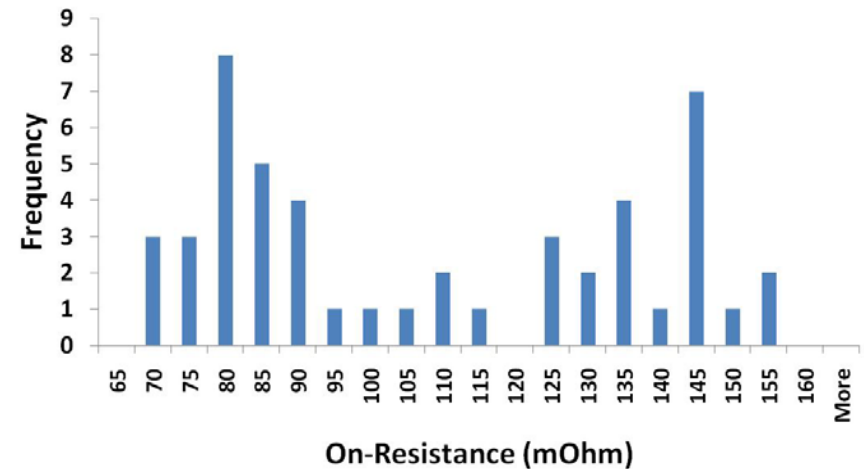
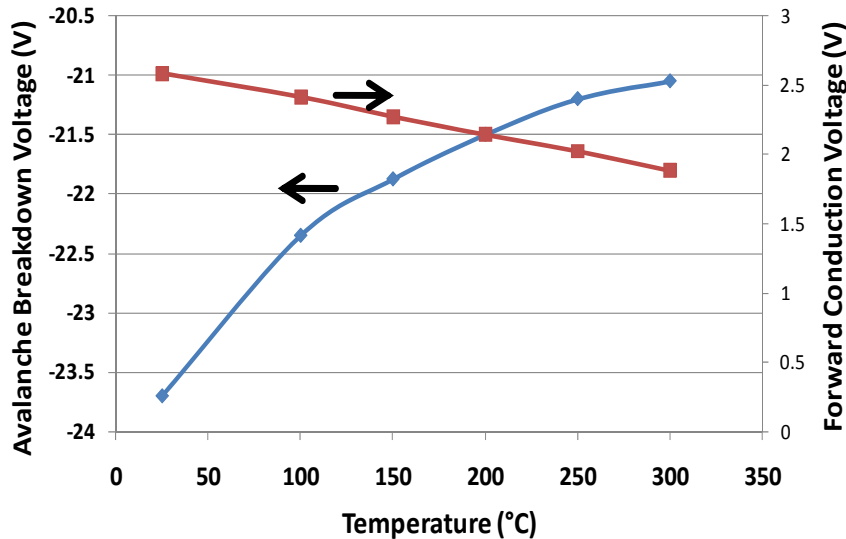
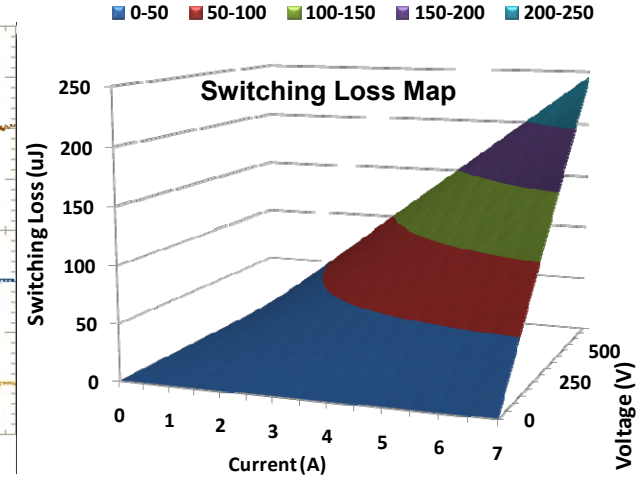
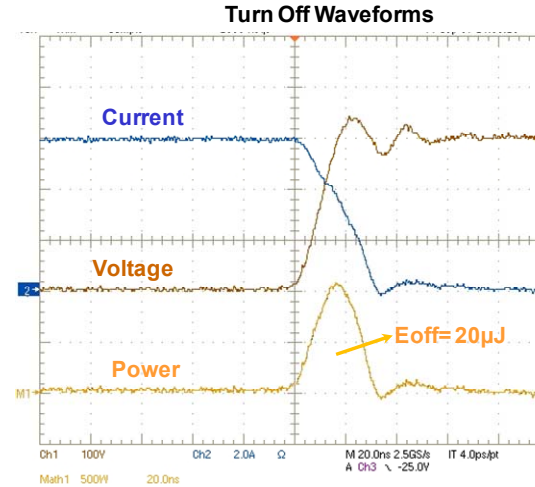
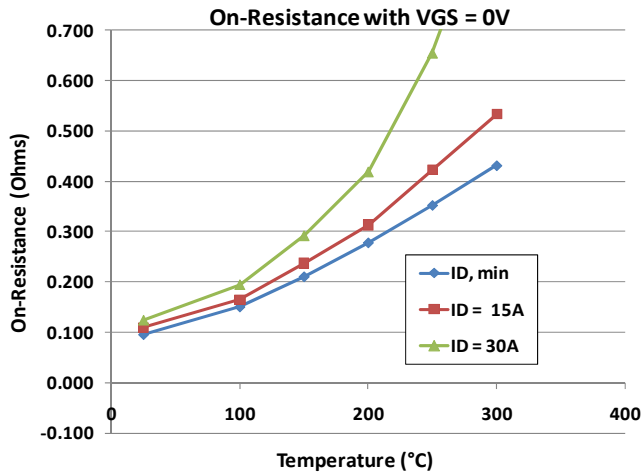
- Several commercial products available
- Schottky diodes from Cree, Inc. and Infineon (SiCED)
  - 300V, 600V and 1200V
  - 20+A and recently 50+A single die

### SiC Controllable Switches

- Normally-off: VJFETs (Lower Voltage), BJTs, MOSFETs and Thyristors
- Normally-on: VJFETs (also MESFETs and SIT)
- SiC normally-on VJFETs is one of the most mature
  - **1200V and 1600V 50+A per die (SiCED)**
  - 600V and 1200V up to 20A per die (Microsemi)
  - SiC SuperJFET, 1200V/50 die (GeneSiC)
- SiC BJTs 1200V up to 20A per die (TranSiC, also Cree)
- SiC MOSFETs 600V,900V and 1200V up to 30A (Cree, Northrop Grumman, Rohm)

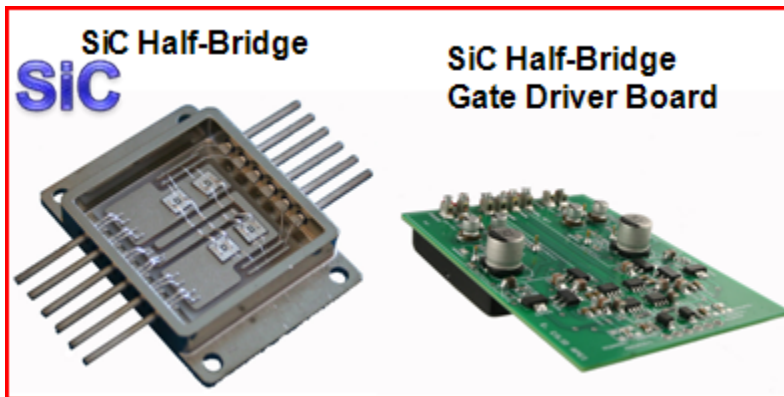
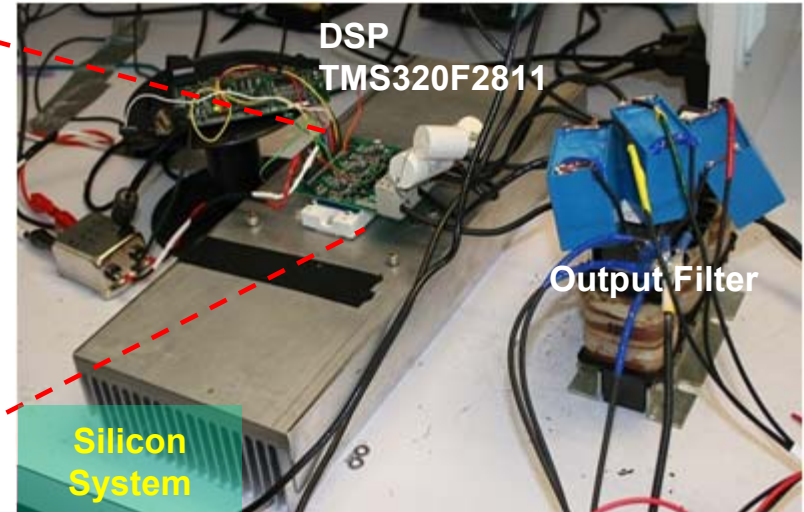
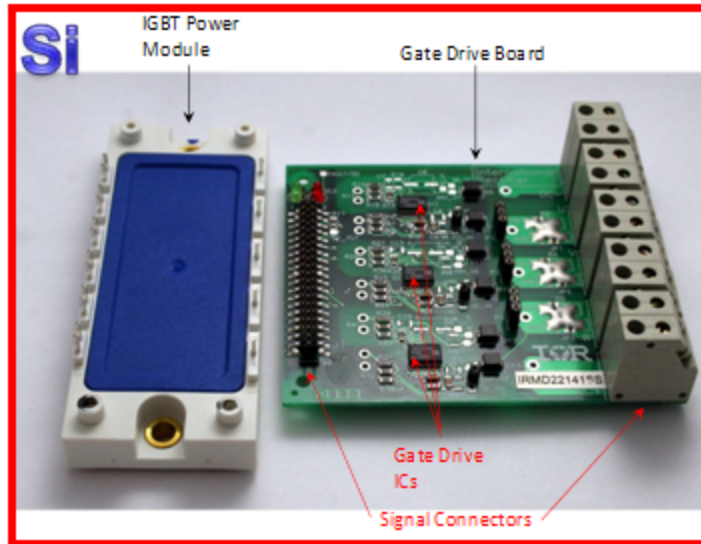


## Characterization of SiC Devices

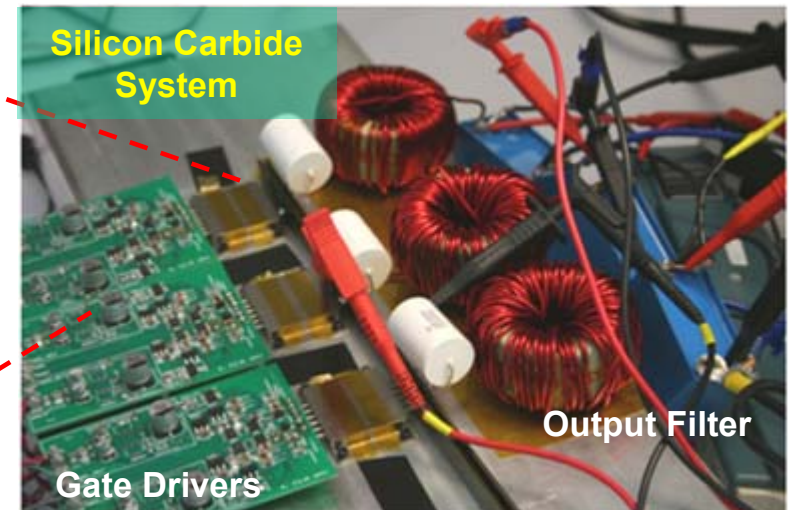




## 10-kVA Three-Phase Inverter Prototypes

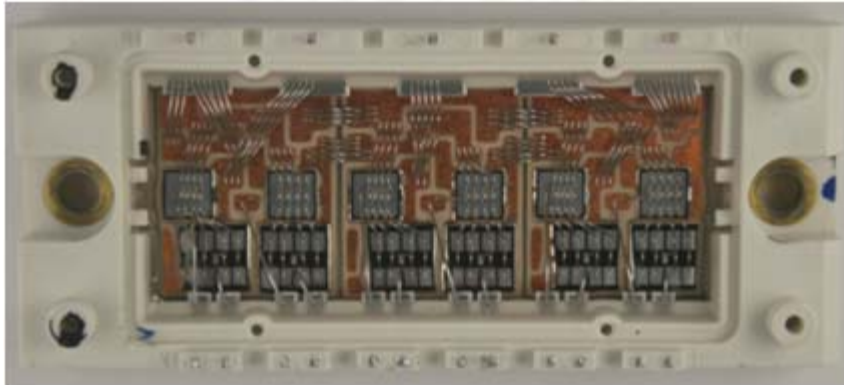


\* Three modules were used



## Comparison of Used Si and SiC Devices

### SI IGBT Brick



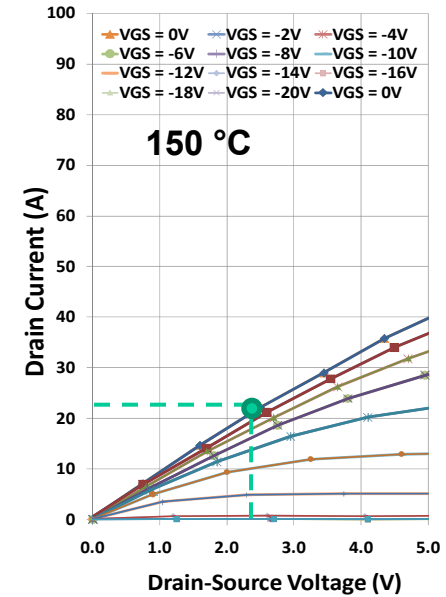
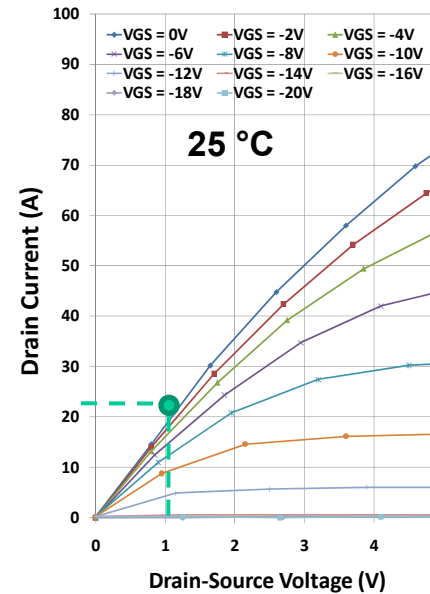
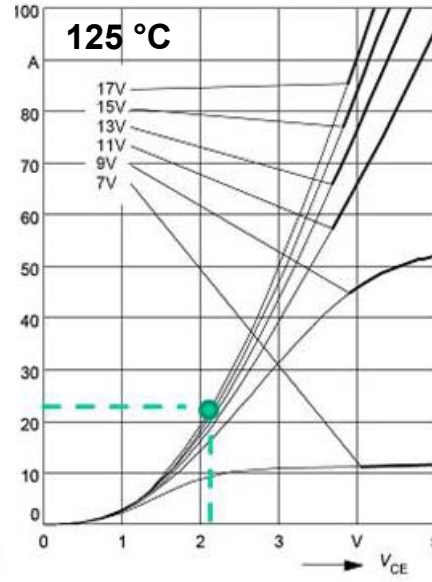
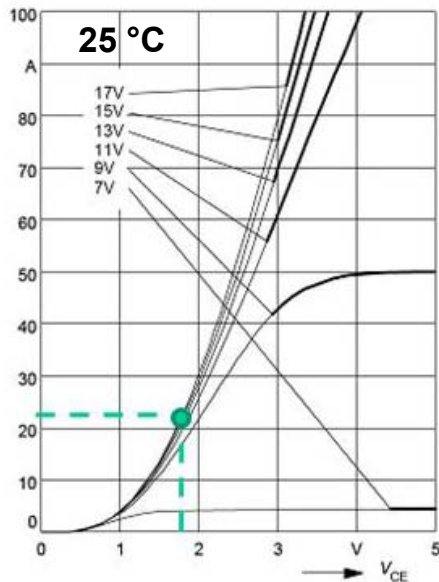
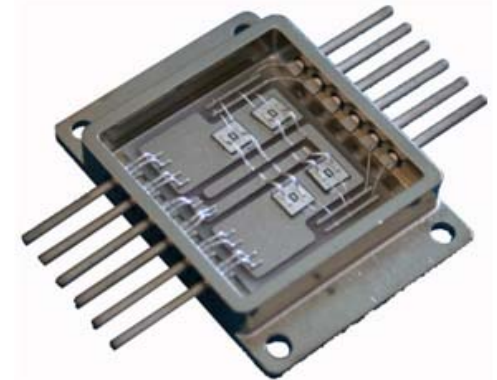
Device Area

Si  
IGBT

SiC  
JFE  
T

SiC  
JFE  
T

### SIC VJFET Brick

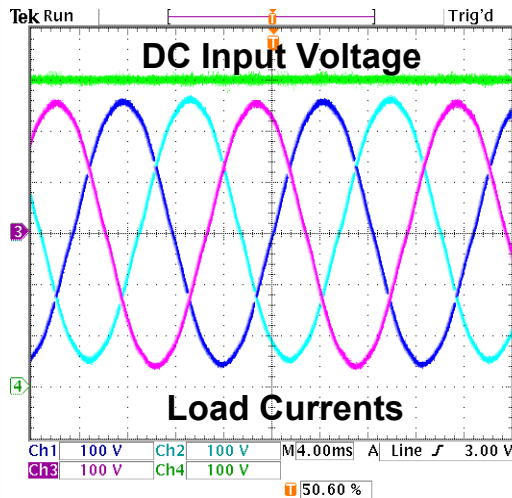




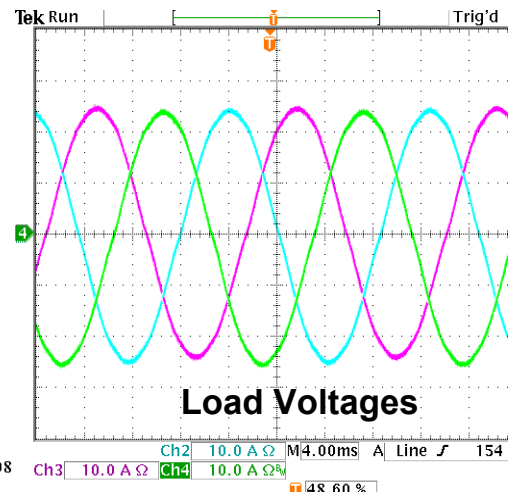
## Characterization of SiC Inverter

### Efficiency Measurements on SiC Inverter

- Variable Resistive Load
- Various LC Output Filters were used
- Several Switching Frequencies: 8 kHz, 10 kHz and 20 kHz
- PWM Generation: Sine Triangular and Space Vector
- Multiple DC Bus Voltages From 450 VDC to 600 VDC
- Measurements were taken under constant ma.



18 Aug 2008 11:17:44



18 Aug 2008 11:18:59

\*08/08/26 04:35:07 FD HOLD MEAS STATUS \FDD  
1ch 2ch 3ch 4ch 5ch 6ch SELECT HPR1

$\eta_1$  : 97.69 %

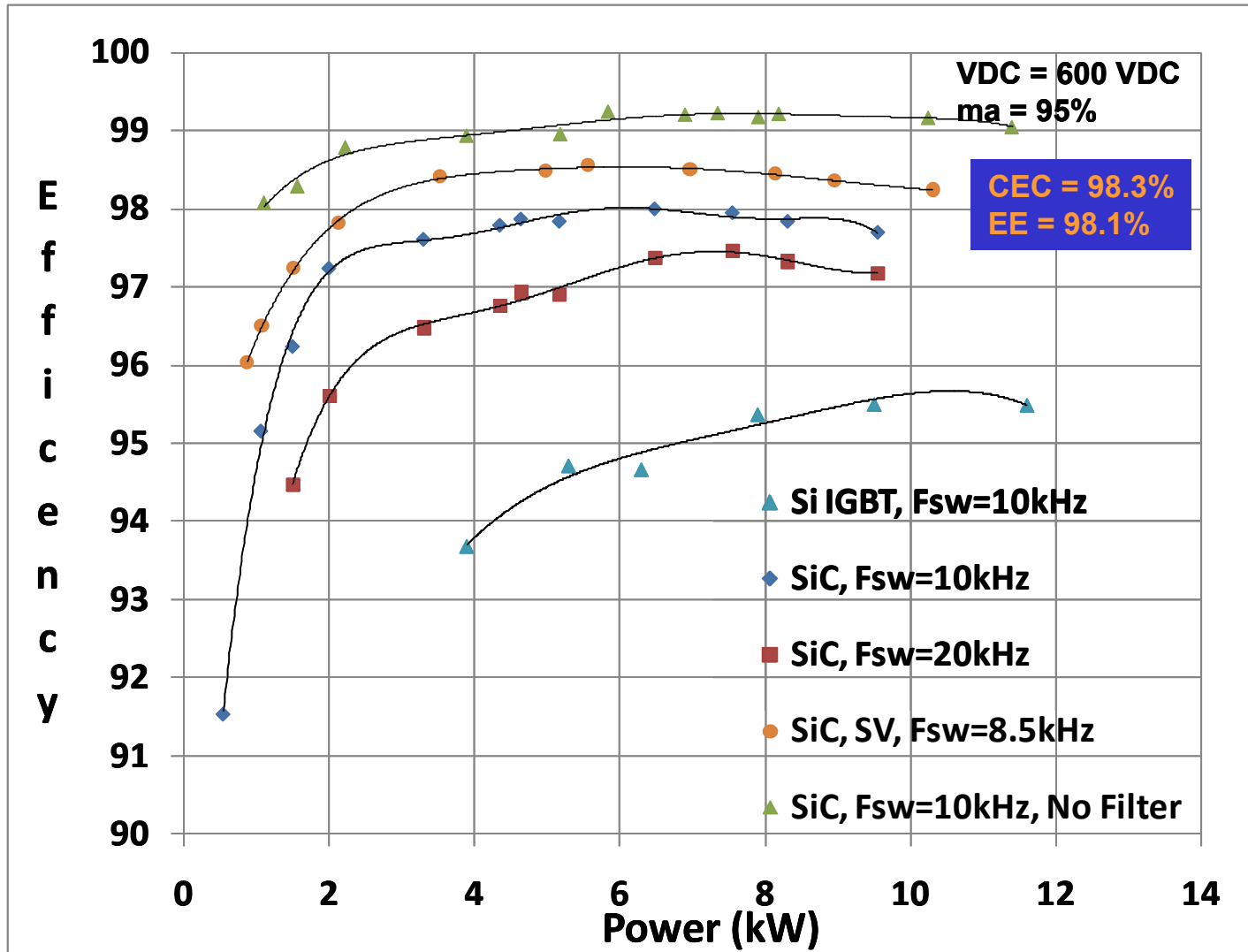
$U_4$  : 600.40 V<sub>RMS</sub>

$I_4$  : 18.101 A<sub>MEAN</sub>

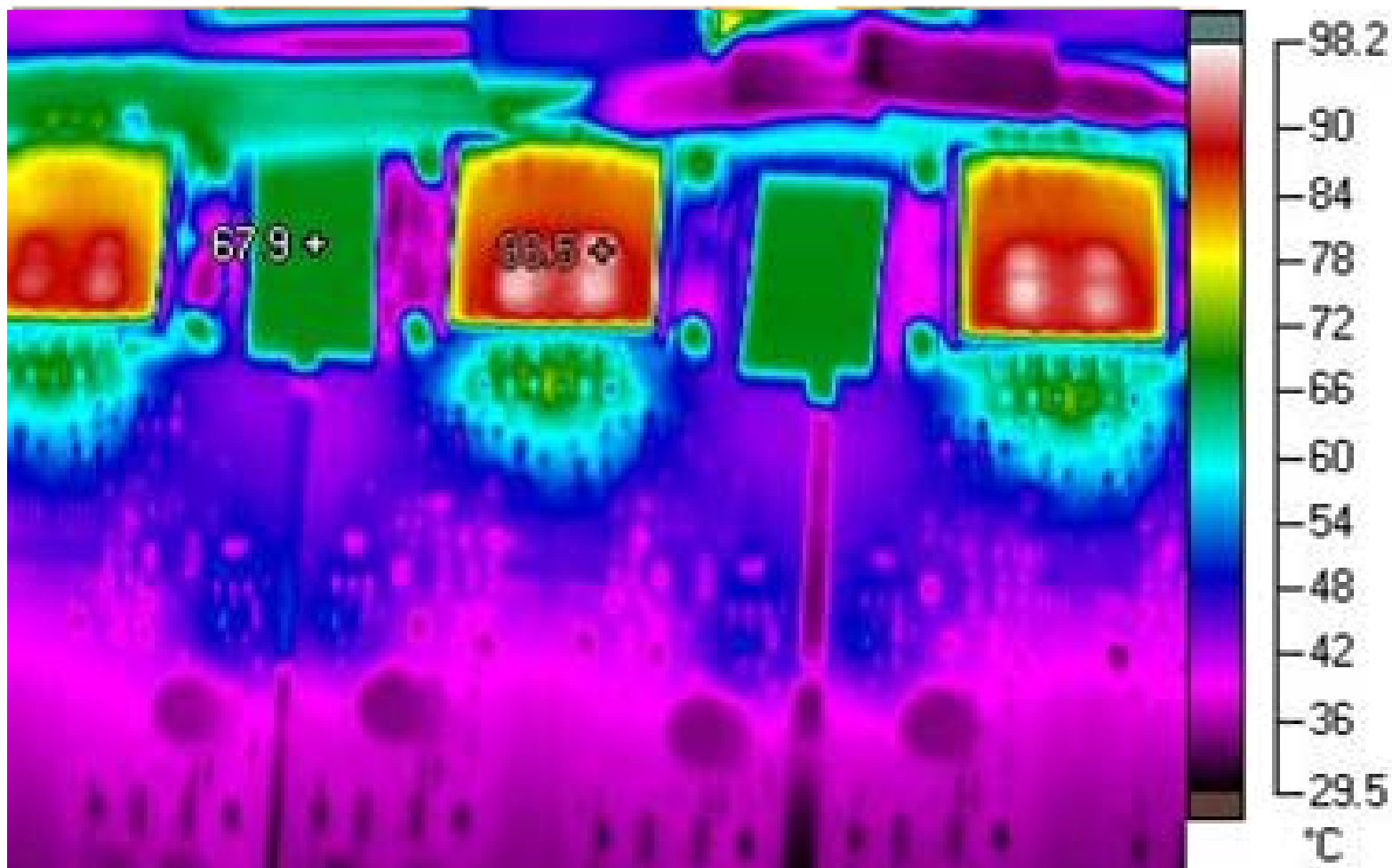
$P_4$  : 9.779 kW

$P_{k4}$  : 0.6020 kV<sub>peak</sub>

## Efficiency Characterization



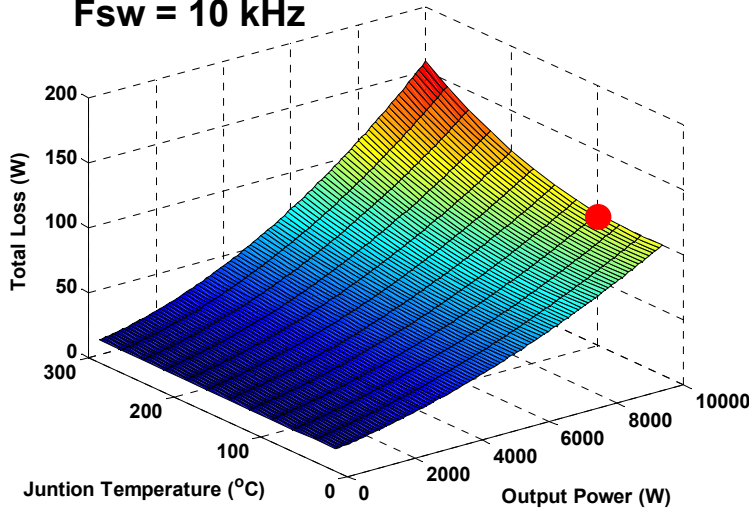
## Potential For Size Optimization



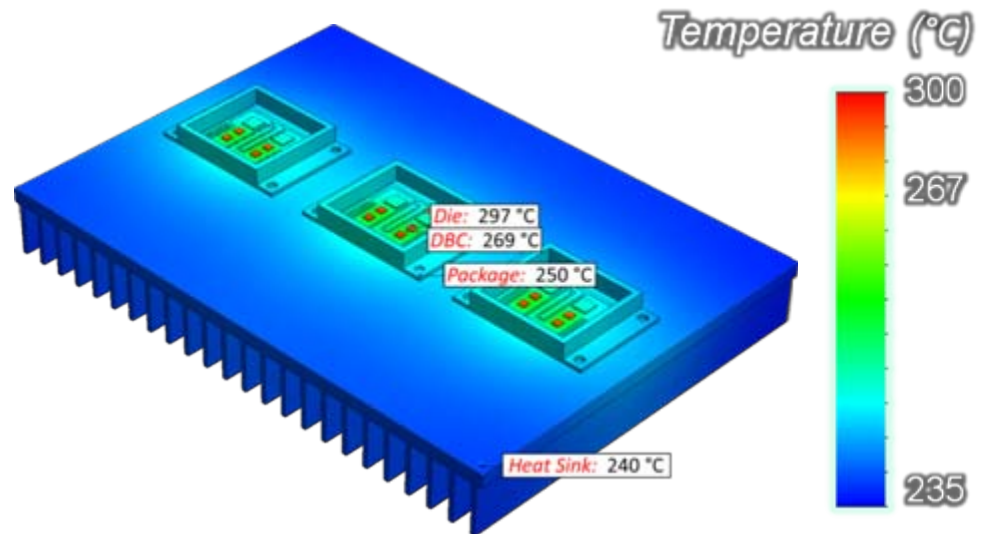
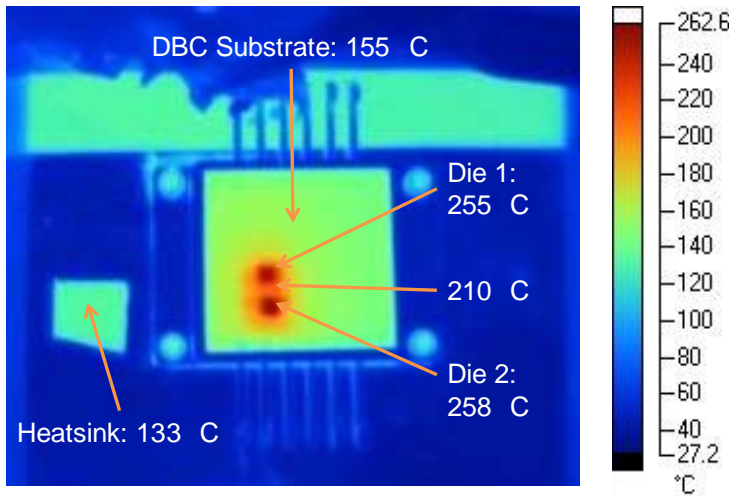
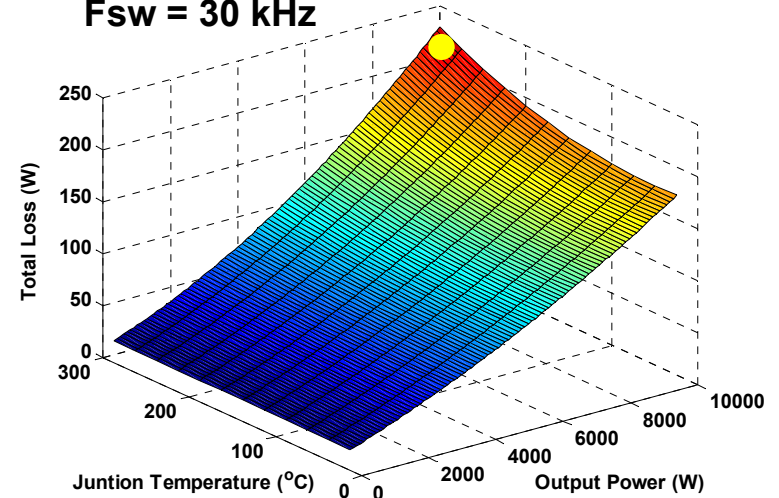


## Potential For Size Optimization

Fsw = 10 kHz



Fsw = 30 kHz



Power Loss = 300 Watts

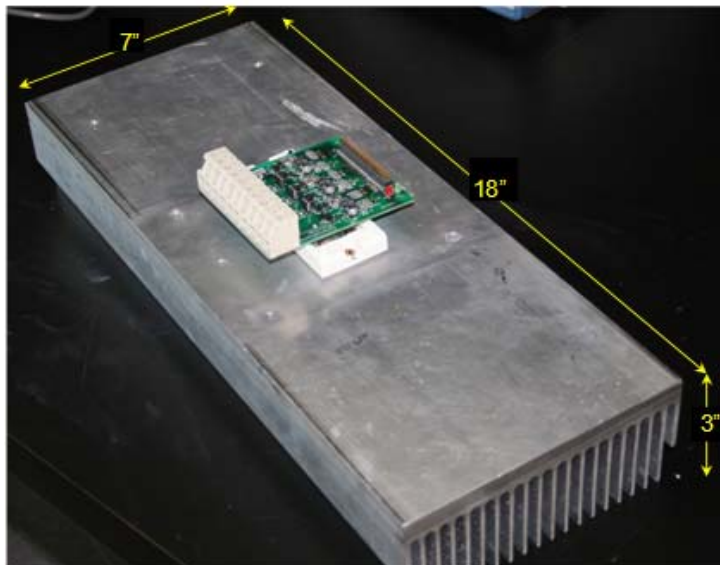
## Potential Size Reduction

### 10-kVA Si IGBT Inverter

Estimated CEC Efficiency = 96%  
Junction Temperature = 100 °C  
Switching Frequency = 10 kHz  
Estimated Power Loss = 230 W  
Heatsink Dimension = 18"x7"x3"  
Volume = 378 in<sup>3</sup>

### 10 kHz LC Filter

Dimensions: 5.75"x8"x5"  
Volume: 230 in<sup>3</sup>

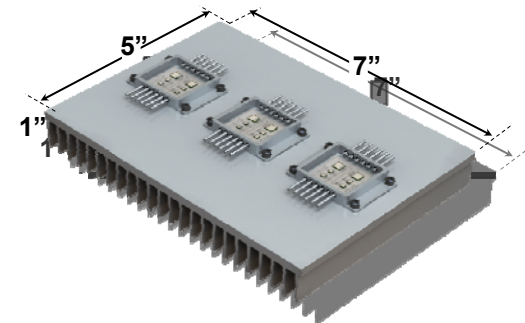


### 10-kVA SiC VJFET Inverter

Estimated CEC Efficiency = 96%  
Junction Temperature = 300 °C  
Switching Frequency = 30 kHz  
Estimated Power Loss = 230 W  
Heatsink Dimension = 7"x5"x1"  
Volume = 35 in<sup>3</sup> (~ 10x reduction)

### 30 kHz LC Filter

Dimensions: 5"x5"x3"  
Volume: ~ 75 in<sup>3</sup> (~ 3x reduction)



## Summary

### ➤ Goal of Phase II work

- Develop a 10-kVA all-SiC three-phase inverter
- System efficiency (>96%)
- Weight and volume minimization options

### ➤ Contributions of Phase II work up to this point

- Design, fabrication, testing and characterization of 10-kVA all SiC Inverter
  - Selection and full characterization of used SiC devices (i.e., static and dynamic characterization vs. temperature, statistical dispersion)
  - Paralleling of multiple SiC devices
  - Developed high temperature (300+ °C) SiC device packaging technology (i.e., wire bonds, die attach, substrate and encapsulation)
  - Developed of gate driver circuitry



## Summary

- **Contributions of Phase II work up to this point (Cont.)**
  - Demonstration of high efficiency operation:
    - Multiple output filters and PWM modulation schemes were compared.
    - Performance comparison to “equivalent” Si system
    - Measured SiC system showed an ECE = 98.3% and EE = 98.1%
  - Demonstration that important weight and volume minimization are possible (tradeoff studies)
  
- **Future work**
  - SiC system characterization while operating at high junction temperature (250+ °C)

## Summary

- **SiC device technology has the potential of greatly increase the performance of power converters**
  - Higher efficiency
  - Smaller size
  - Higher reliability
  - And ultimate lower cost
  
- **Where do we go from here?**
  - Higher voltage and higher power applications
    - Power capability of single-chip devices
  - Advances in key components
  - Reliable packaging technologies
  - SiC Cost

## Acknowledgments

- **Department of Energy (DOE)**
  - Energy Storage System Program, directed by Dr. Imre Gyuk
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